

386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100
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EMC TEST REPORT For FCC

Test Report No. : CTK03-F106

Date of Issue : September 26, 2003

Model/Type No: : Digimax U-CA3

Kind of Product : Digital Camera

Applicant : Samsung Techwin Co., Ltd.

Applicant Address : 145-3 Sangdaewon 1 dong, Chungwon-ku, Sungnam City,

Kyungki-do, Korea

Manufacturer : 1) Samsung Techwin Co., Ltd.

2) Tianjin Samsung Opto-Electronics Co., Ltd.

Manufacturer Address : 1) 42, Sungju-dong, Changwon City, Kyungnam, Korea

2) 7 Pingchang Road, Nankai Dist., Tianjin, China

Contact Person : Kun-Sop, Kim (Manager)

Telephone : +82-31-740-8253

Received Date : September 18, 2003

Test period : Start: September 19, 2003 End: September 25, 2003

Test Results : X In Compliance Not in Compliance

The test results presented in this report relate only to the object tested.

CERTITEK Standards Laboratory Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Young-Joon, Park EMC Test Engineer

Date: September 26, 2003

Reviewed by

James Hong

EMC Technical Manager

Date: September 26, 2003

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REPORT REVISION HISTORY

Date	Revision	Page No
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1.0 General Product Description

1.0.1 Tested Equipment

		Model Tests p	alless otherwise indicated, all tests were conducted on odel Digimax U-CA3. sts performed on Model were considered to be presentative of Model(s)						
1.0.2	Equip	ment S	Size, Mobility and Identification						
		sions: y:	102 by 53.8 by 31.6 (WxHxD) ⊠ mm ☐ in ☐ Hand-Held ☐ Table-top ☐ Floor-standing ☐ -						
	Serial I	No.:	Prototype						
1.0.3	Electr	ical Ra	itings						
	Input:		Adaptor: 100-250Vac, 50/60Hz, 0.3A EUT: 3.3Vdc						
	Output	::	Adaptor: 3.3Vdc, 2.0A EUT: -						
1.0.4	Test \	/oltage	e & Frequency (Using the adaptor)						
			ed otherwise on the individual data sheet or test results, the equency was as indicated below.						

1.0.5 Clock & Other Frequencies Utilized

120Vac

60Hz

DSC25: 48.00MHz, 27.00MHz TG/CDS/AGC: 48.6MHz AUDIO CODEC: 11.2896MHz

RTC: 32.768kHz

1.1 Model Differences

Voltage: Frequency:

Not applicable

1.2 Device Modifications

The following modifications were necessary for compliance:

Not applicable

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test

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1.3 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
Adaptor	Ault Inc.	PW137	-	-
Desk Top PC	Hewlett-Packard Company	PD1059P	-	DoC
Monitor	Hewlett-Packard Company	P4829	TW14383731	DoC
Keyboard	Samsung	SEM-DT35	33008109	DoC
Mouse (PS/2 type)	Samsung	OMS3CB	0303009873	DoC
Mouse (Serial type)	Microsoft	BASM1	4475951-20000	DoC

#	Description	Ferrite Core	Length (m)	Other Details
1	AC power cable, Unshielded	No	1.5	Connect to AC power
2	AC power cable, Unshielded	No	1.8	Connect to AC power
3	AC power cable, Unshielded	No	1.8	Connect to AC power
4	DC output cable, Unshielded	Yes	1.5	Between the EUT and Adaptor
5	USB cable, Shielded	Yes	1.2	Between the EUT and PC
6	Monitor cable, Shielded	Yes	1.8	Between the PC and Monitor
7	Mouse cable, Shielded	No	2.1	Serial type
8	Mouse cable, Shielded	No	1.8	PS/2 type
9	Keyboard cable, Shielded	No	1.5	PS/2 type

1.4 Test Software □ Pinging □ Not applicable 1.5 EUT Operating Mode(s) Equipment under test was operated during the measurement under the following conditions: □ Test program (H-Pattern) □ Test program (color bar) □ Standby □ Test program (customer specific) □ Practice operation : PC mode (Downloading stored images)

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1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.7 Test Facility

The measurement facility is located at 386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

1.8 **Measurement Procedure**

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

* Measurement procedures was In accordance with ANSI C63.4-1992 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 and 10 meter Open Area Test Sites to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	R-948, C-986
KOREA	MIC	EMI (CE, RE) EMS (ESD, Burst, RS, Surge, CS, Power-Frequency Susceptibility, Voltage Dips and Short Interruptions)	No. 51, KR0025
International	KOLAS	EMC	KOL45
Europe	GLAS	EMC EN 55011, EN 55022, EN 55024, EN 61326, EN 50130-4, EN 50081-1, EN 50081-2, EN 50082-1, EN 50082-2, EN 61000-6-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-3-2, EN 61000-3-3	TÜV No.13000796-02

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2.0 Emissions Test Regulations

The emissions tests were performed accord	ing to following regulat	ions:
☐ EN 50081-1:1992		
☐ EN 55011:1998 +A1:1999	☐ Group 1 ☐ Class A	Group 2 Class B
☐ EN 55013:1990 +A12:1994 +A13:1996 ☐ EN 55013:2001	+A14:1999	
☐ EN 55014-1:1993 +A1:1997 +A2:1999	☐ Household appli☐ Portable tools☐ Semiconductor	ances and similar
☐ EN 55014-1:2000 ☐ EN 55014-2:1997	_	
☐ EN 55015:1996 +A1:1997 +A2:1999 ☐ EN 55015:2000		
☐ EN 55020:1994 +A11:1996 +A13:1999 ☐ EN 55020:1994 +A11:1996 +A12:1999		9
☐ EN 55022:1994 +A1:1995 +A2:1997 ☐ EN 55022:1998 +A1:2000	☐ Class A ☐ Class A	☐ Class B ☐ Class B
☐ EN 61000-3-2:1995 +A1:1998 +A2:199☐ EN 61000-3-2:1995 +A1:1998 +A2:199☐ EN 61000-3-2:2000☐ EN 61000-3-3:1995		
☐ VCCI V-3/99.05 : 1999	☐ Class A	☐ Class B
	☐ Class A	
☐ AS 3548 (1992)	☐ Class A	☐ Class B
☐ CISPR 22 (1997)	☐ Class A	⊠ Class B

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2.1 Conducted Voltage Emissions

Test Date

September 19, 2003

Test Location EMI-CE: Shielded Roor	n		
Test Instruments ☐ Field Strength Meter	er Rohde & Schwarz	ESHS30	828144/002
Test Accessories			
□ LISN	EMCO	3825/2	9409-2246
□ LISN	EMCO	3825/2	9607-2574
Control PC	HP	Vectra 500	SG72000192
Frequency Range of 150 kHz to 30 MHz depth 450 kHz to 30 MHz Instrument Setting			
IF Band Width: 9 kHz	•		
Test Results The requirements are:			
METNOT METNOT APPLICABLE	minimum margin is 14.6 dE limit exceeded by maximum		MHz

Remarks

See Appendix A for test data.

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2.2 Radiated Electric Field Emissions

Test Date September 22, 2003			
Test Location ⊠ EMI-OATS: Testing was p □ EMI-OATS: Testing was p			
Test Instruments ☑ Field Strength Meter	Rohde & Schwarz	ESVS30	826638/008
Test Accessories ULTRA Broadband Antenr Bi-conical Antenna Bi-conical Antenna Log-periodic Antenna Frequency Range of Me	Schwarzbeck EMCO EMCO	HL562 BBA9106 3110B 3146	361324/014 41-00201 9607-2564 9607-4567
30 MHz to 1 GHz Instrument Settings IF Band Width: 120 kHz			
Test Results The requirements are:			
	mum margin is 3.3 dBu\ exceeded by maximum		

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Remarks

See Appendix A for test data

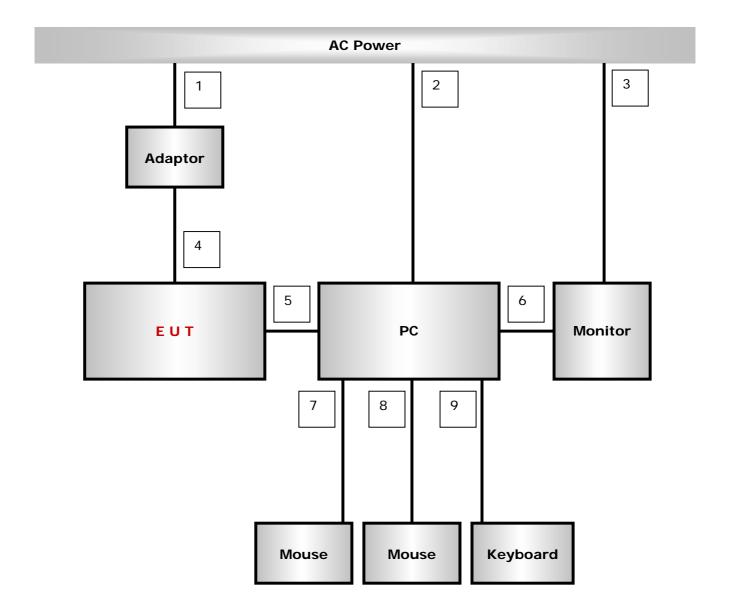
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Configuration



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APPENDIX A - TEST DATA

Conducted Voltage Emissions (Quasi-Peak reading)

Frequency	Corre	ection			Quasi-peak				Ave	rage	
. ,	Fac	tor	Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
0.20	1.7	0.1	Н	63.6	47.2	49.0	14.6	53.6			
0.50	0.5	0.1	N	56.0	38.3	38.9	17.1	46.0			
3.30	0.3	0.1	N	56.0	40.2	40.6	15.4	46.0			
3.42	0.3	0.1	Н	56.0	39.3	39.7	16.3	46.0			
28.47	0.6	0.4	Н	60.0	41.8	42.8	17.2	50.0			
28.57	0.6	0.4	Н	60.0	42.0	43.0	17.0	50.0			
28.68	0.6	0.4	Н	60.0	42.0	43.0	17.0	50.0			
28.78	0.6	0.4	Н	60.0	41.8	42.8	17.2	50.0			

^{*} If the average limit is met when a quasi-peak detector is used, the EUT shall be deemed to meet both limit and measurement with the average detector is unnecessary.

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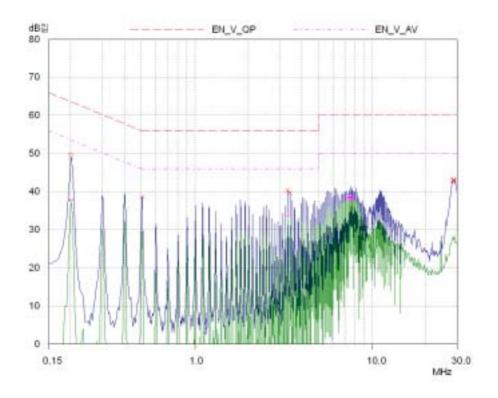
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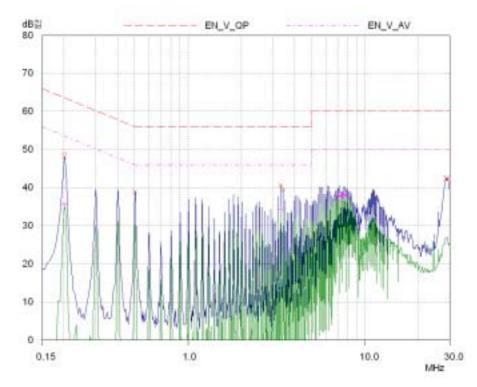
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Radiated Electric Field Emissions (Quasi-Peak reading)

Frequency	Reading	Pol.	Height	Correction Factor		Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
48.65	10.0	V	1.0	9.60	1.30	30.0	20.90	9.10
72.90	17.1	V	1.4	7.30	1.70	30.0	26.10	3.90
121.50	13.4	V	1.0	9.55	2.10	30.0	25.05	4.95
145.80	16.5	V	1.9	7.80	2.40	30.0	26.70	3.30
162.80	8.9	V	1.8	7.30	2.60	30.0	18.80	11.20
458.90	12.2	Н	3.5	14.80	4.40	37.0	31.40	5.60
468.75	11.4	Н	2.0	15.00	4.40	37.0	30.80	6.20
493.12	12.7	Н	3.2	15.30	4.40	37.0	32.40	4.60
505.13	6.8	Н	3.0	15.70	4.80	37.0	27.30	9.70

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